


<b>Search Notes</b> 	<b>Application/Control No.</b> 10624478	<b>Applicant(s)/Patent Under Reexamination</b> LIN, CHE-LI
	<b>Examiner</b> Lui, Donna V	<b>Art Unit</b> 2629

SEARCHED			
Class	Subclass	Date	Examiner
345	173	11/15/2006	DL
178	18.03	11/15/2006	DL
178	18.01	11/15/2006	DL
178	20.01	11/15/2006	DL
345	102	11/15/2006	DL
349	57	11/15/2006	DL
349	61	11/15/2006	DL

SEARCH NOTES		
Search Notes	Date	Examiner
178/18.01-18.09 (US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB)	11/15/2006	DL
178/20.01-20.04 (US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB)	11/15/2006	DL
349/56-67 (US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB)	11/15/2006	DL
345/173-178 (US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB)	11/15/2006	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
178	18.03	11/15/2006	DL
345	102	11/15/2006	DL
345	173	11/15/2006	DL
349	57	11/15/2006	DL
349	61	11/15/2006	DL